Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/679,471	LEE ET AL.	
Examiner	**Art Unit**	
Scott Bushey	1724	

SEARCHED			
Class	Subclass	Date	Examiner
261	79.2,96,98 102,105, 109	1/6/2005	CSB

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Inventor Name Search and Text Search	1/6/2005	CSB